

Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/733,990	HAN ET AL.
	Examiner	Art Unit
	Khawar Iqbal	2617

ORIGINAL			CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
455	561	455	424	67.11	69			
INTERNATIONAL CLASSIFICATION			370	252	329	278		
H	0	4	M	1/00				
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<i>Khawar Iqbal 9-7-07</i> Assistant Examiner) (Date)			<i>Duc M. Nguyen</i> SUPERVISORY PRIMARY EXAMINER TECHNOLOGY CENTER 2600 (Primary Examiner) <i>9/11/07</i> (Date)			Total Claims Allowed: 19		
<i>(Legal Instruments Examiner)</i> (Date)						O.G. Print Claim(s) 01	O.G. Print Fig. 04	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1	31	61	91	121	151	181
2		32	62	92	122	152	182
3		33	63	93	123	153	183
4		34	64	94	124	154	184
2	5	35	65	95	125	155	185
3	6	36	66	96	126	156	186
4	7	37	67	97	127	157	187
5	8	38	68	98	128	158	188
6	9	39	69	99	129	159	189
7	10	40	70	100	130	160	190
8	11	41	71	101	131	161	191
9	12	42	72	102	132	162	192
10	13	43	73	103	133	163	193
11	14	44	74	104	134	164	194
12	15	45	75	105	135	165	195
13	16	46	76	106	136	166	196
15	17	47	77	107	137	167	197
14	18	48	78	108	138	168	198
18	19	49	79	109	139	169	199
16	20	50	80	110	140	170	200
17	21	51	81	111	141	171	201
19	22	52	82	112	142	172	202
23		53	83	113	143	173	203
24		54	84	114	144	174	204
25		55	85	115	145	175	205
26		56	86	116	146	176	206
27		57	87	117	147	177	207
28		58	88	118	148	178	208
29		59	89	119	149	179	209
30		60	90	120	150	180	210